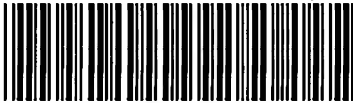


Search Notes

Application/Control No.

10/658,332

Examiner

Allahyar Kasraian

Applicant(s)/Patent under
Reexamination

FUJISHIRO, YOSHIYA

Art Unit

2609

SEARCHED

Class	Subclass	Date	Examiner
370	503	3/29/2007	AK
370	518	3/29/2007	AK
375	359	3/29/2007	AK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
370	503	3/29/2007	AK
375	240.28	3/29/2007	AK

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Image and keyword search in USPTO, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	3/29/2007	AK
Inventor name and Assignee search in PALM ExPo and EAST	3/29/2007	AK
(((370/503,521,304,506- 513,518,.ccds.) or (375/354,356,359,365,366,368.cds.)) and (synchron\$8 same (count\$3 near8 (clock	3/29/2007	AK
IEEE Xplore http://ieeexplore.ieee.org/Xplore/DynWel.jsp Google http://www.google.com	3/29/2007	AK
EPO Data base http://ep.espacenet.com	3/29/2007	AK